

OptiMOS®-T2 Power-Transistor





Features

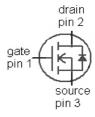
- N-channel Enhancement mode
- AEC qualified
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- Green Product (RoHS compliant)
- 100% Avalanche tested

Product Summary

V _{DS}	40	V
R _{DS(on),max} (SMD version)	4.0	mΩ
I _D	80	Α

PG-TO263-3-2 PG-TO262-3-1 PG-TO220-3-1

Туре	Package	Marking
IPB80N04S4L-04	PG-TO263-3-2	4N04L04
IPI80N04S4L-04	PG-TO262-3-1	4N04L04
IPP80N04S4L-04	PG-TO220-3-1	4N04L04



Maximum ratings, at T_j =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current ¹⁾	I _D	T _C =25°C, V _{GS} =10V	80	А
		$T_{\rm C}$ =100°C, $V_{\rm GS}$ =10 $V^{2)}$	80	
Pulsed drain current ²⁾	I _{D,pulse}	T _C =25°C	320	
Avalanche energy, single pulse ²⁾	E _{AS}	/ _D =40A	100	mJ
Avalanche current, single pulse	I _{AS}	-	80	Α
Gate source voltage	V_{GS}	-	+20/-16	V
Power dissipation	P_{tot}	T _C =25°C	71	W
Operating and storage temperature	$T_{\rm j},T_{\rm stg}$	-	-55 +175	°C
IEC climatic category; DIN IEC 68-1	-	-	55/175/56	



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Parameter	Symbol Conditions		Values			Unit
			min.	typ.	max.	
Thermal resistance, junction - case	R _{thJC}	-	-	-	2.1	K/W
Thermal resistance, junction - ambient, leaded	R _{thJA}	-	-	-	62	
SMD version, device on PCB	R_{thJA}	minimal footprint	-	-	62	
		6 cm ² cooling area ³⁾	-	-	40	

Electrical characteristics, at $T_{\rm j}$ =25 °C, unless otherwise specified

Static characteristics

Drain-source breakdown voltage	V _{(BR)DSS}	V _{GS} =0V, I _D = 1mA	40	-	-	V
Gate threshold voltage	$V_{\rm GS(th)}$	$V_{\rm DS} = V_{\rm GS}$, $I_{\rm D} = 35 \mu A$	1.2	1.7	2.2	
Zero gate voltage drain current	IDSS	V _{DS} =40V, V _{GS} =0V	-	0.02	1	μΑ
		$V_{\rm DS}$ =18V, $V_{\rm GS}$ =0V, $T_{\rm j}$ =85°C ²⁾	-	1	20	
Gate-source leakage current	I _{GSS}	V _{GS} =20V, V _{DS} =0V	-	1	100	nA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} =4.5V, I _D =40A	-	5.1	6	mΩ
		$V_{\rm GS}$ =4.5V, $I_{\rm D}$ =40A, SMD version	ı	4.8	5.7	
		V _{GS} =10 V, I _D =80 A	-	3.7	4.3	
		$V_{\rm GS}$ =10 V, $I_{\rm D}$ =80 A, SMD version	-	3.4	4.0	

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Parameter	Symbol	mbol Conditions		Values		
			min.	typ.	max.	
Dynamic characteristics ²⁾						
Input capacitance	C iss		-	3610	4690	pF
Output capacitance	C _{oss}	V _{GS} =0V, V _{DS} =25V, f=1MHz	-	650	840]
Reverse transfer capacitance	C _{rss}		-	30	69	
Turn-on delay time	t _{d(on)}		-	7	-	ns
Rise time	tr	V _{DD} =20V, V _{GS} =10V,	-	12	-	- - -
Turn-off delay time	$t_{\text{d(off)}}$	$I_{\rm D}$ =80A, $R_{\rm G}$ =3.5 Ω	-	22	-	
Fall time	t _f		-	31	-	
Gate Charge Characteristics ²⁾						
Gate to source charge	Q _{gs}		-	12	16	nC
Gate to drain charge	Q _{gd}	V _{DD} =32V, I _D =80A,	-	5	12	
Gate charge total	Qg	V _{GS} =0 to 10V	-	46	60	
Gate plateau voltage	V _{plateau}		-	3.2	-	V
Reverse Diode						
Diode continous forward current ²⁾	Is	T -25°C	-	-	80	А
Diode pulse current ²⁾	I _{S,pulse}	-T _C =25°C	-	-	320	
Diode forward voltage	V _{SD}	V _{GS} =0V, I _F =80A, T _j =25°C	-	0.9	1.3	V
Reverse recovery time ²⁾	t _{rr}	V_R =20V, I_F =50A, di_F/dt =100A/ μ s	-	39	-	ns
Reverse recovery charge ²⁾	Q _{rr}		-	35	-	nC

 $^{^{1)}}$ Current is limited by bondwire; with an $R_{\rm thJC}$ = 2.1K/W the chip is able to carry 98A at 25°C.

²⁾ Defined by design. Not subject to production test.

 $^{^{3)}}$ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm 2 (one layer, 70 μ m thick) copper area for drain connection. PCB is vertical in still air.



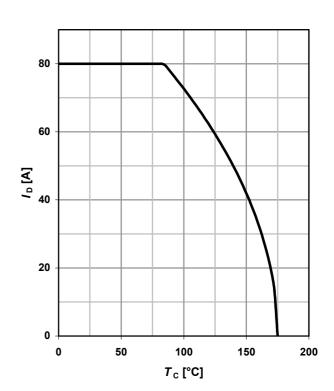
1 Power dissipation

$$P_{\text{tot}} = f(T_{\text{C}}); V_{\text{GS}} \ge 6 \text{ V}$$

75 62.5 50 25 12.5 0 0 0 50 100 150 200 T_C [°C]

2 Drain current

$$I_D = f(T_C); V_{GS} \ge 6 \text{ V}; \text{SMD}$$



3 Safe operating area

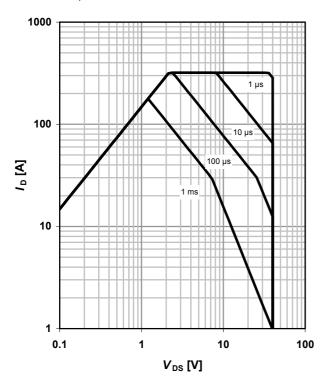
$$I_D = f(V_{DS}); T_C = 25 \,^{\circ}\text{C}; D = 0; \text{SMD}$$

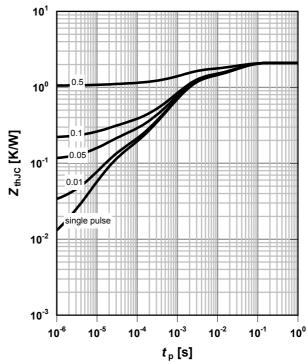
parameter: t_p

4 Max. transient thermal impedance

$$Z_{\rm thJC} = f(t_{\rm p})$$

parameter: $D = t_p/T$







5 Typ. output characteristics

 $I_D = f(V_{DS}); T_i = 25 \text{ °C}; SMD$

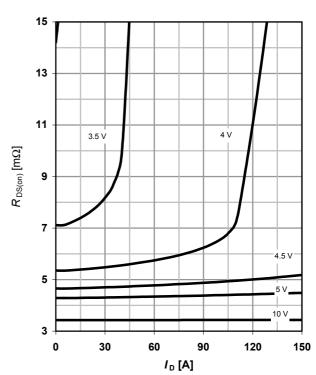
parameter: V_{GS}

300 10 V 5 V 4.5 V 4.5 V 60 3.5 V 60 3.5 V 60 3.5 V 70 S [V]

6 Typ. drain-source on-state resistance

 $R_{DS(on)} = f(I_D); T_j = 25 \text{ °C}; SMD$

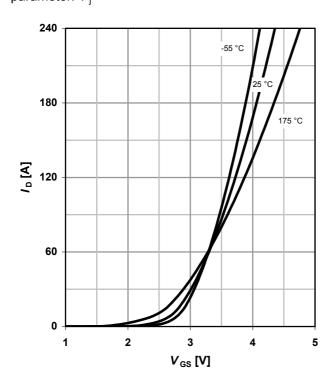
parameter: V_{GS}



7 Typ. transfer characteristics

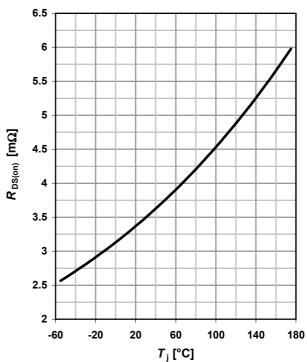
 $I_D = f(V_{GS}); V_{DS} = 6V$

parameter: T_i



8 Typ. drain-source on-state resistance

$$R_{DS(on)} = f(T_j); I_D = 80 \text{ A}; V_{GS} = 10 \text{ V}; SMD$$





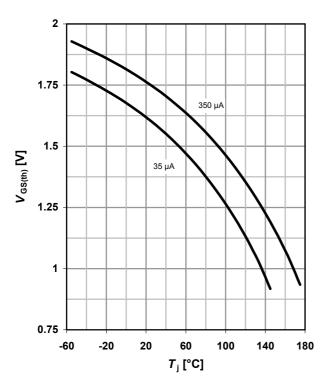
9 Typ. gate threshold voltage

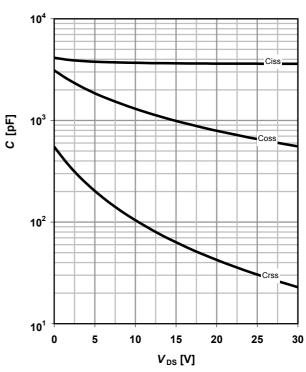
 $V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$

parameter: I_D

10 Typ. capacitances

$$C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$$





11 Typical forward diode characteristicis

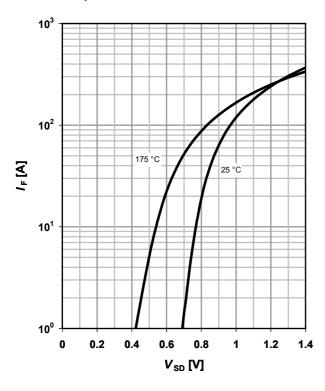
 $IF = f(V_{SD})$

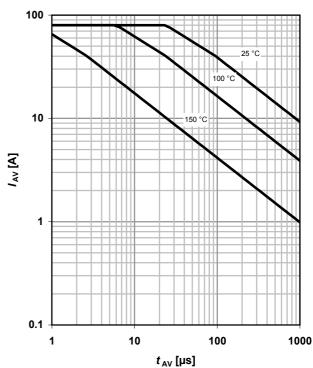
parameter: T_i

12 Avalanche characteristics

 $I_{AS} = f(t_{AV})$

parameter: T_{i(start)}







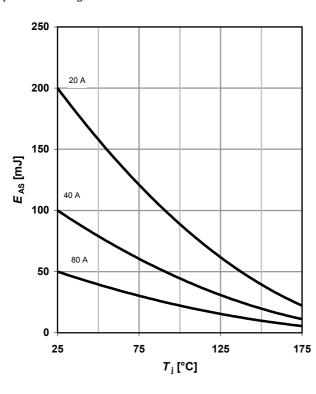
13 Avalanche energy

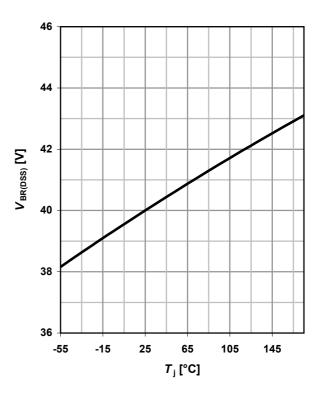
$E_{AS} = f(T_i)$

parameter: I_D

14 Drain-source breakdown voltage

$$V_{BR(DSS)} = f(T_j); I_D = 1 \text{ mA}$$

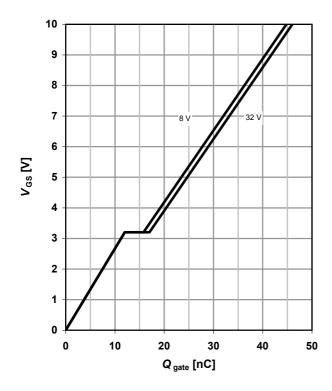




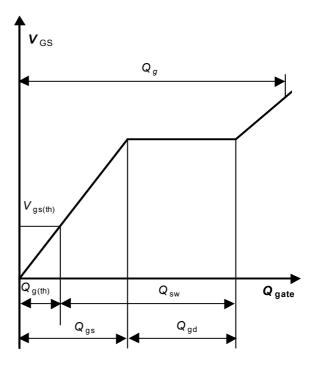
15 Typ. gate charge

 $V_{\rm GS}$ = f($Q_{\rm gate}$); $I_{\rm D}$ = 80 A pulsed

parameter: V_{DD}



16 Gate charge waveforms





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IPB80N04S4L-04 IPI80N04S4L-04, IPP80N04S4L-04

Revision History

Version	Date		Changes
Revision 1.0		14.04.2010	Final Data Sheet